

U.S. DEPARTMENT OF COMMERCE
PATENT AND TRADEMARK OFFICEINFORMATION DISCLOSURE
STATEMENTDocket Number:
10191/4533Application Number
To be assignedFiling Date
HerewithExaminer
To be assignedArt Unit
To be assignedInvention Title
OPTICAL IMAGING SYSTEMInventor(s)
Vincent THOMINET et al.

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1. In accordance with the duty of disclosure under 37 C.F.R. § 1.56 and in conformance with the procedures of 37 C.F.R. §§ 1.97 and 1.98 and M.P.E.P. § 609, attorneys for Applicants hereby bring the following references to the attention of the Examiner. The references are listed on the attached modified PTO Form No. 1449. It is respectfully requested that the information be expressly considered during the prosecution of this application, and that the references be made of record therein and appear among the "References Cited" on any patent to issue therefrom.
2. A copy of the patents listed on the modified PTO form 1449 are enclosed, unless otherwise indicated.

Dated: 6/23/06By: 18 (R. No. 41072)
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INFORMATION DISCLOSURE STATEMENT BY APPLICANT PTO-1449		DOCKET NO. 10191/4533	SERIAL NO. To be assigned
		APPLICANT THOMINET, Vincent et al.	
		FILING DATE To be assigned	GROUP To be assigned

U. S. PATENT DOCUMENTS

EXAMINER INITIAL	PATENT/ PUBLICATION NUMBER	PATENT/PUBLICATION DATE	NAME	CLASS	SUBCLASS	FILING DATE
	* 4,875,777	October 24, 1989	HARDING et al.			
	* 3,927,254	December 16, 1975	LESSMAN et al.			

- * Copy of reference is not enclosed because reference is cited and described in Search Report (copy of reference provided by the International Searching Authority).

FOREIGN PATENT DOCUMENTS

EXAMINER INITIAL	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
						Yes	No
	709 431	May 26, 1954	Great Britain			X**	
	673 971	June 18, 1952	Great Britain			X**	
	0 047 936	March 24, 1982	EPO			X**	
	0 572 732	October 21, 1998	EPO			X	
/SL/	WO 02/14858	February 21, 2002	PCT				X**
/SL/	WO 01/27558	April 19, 2001	PCT				X**

- * Copy of reference is not enclosed because reference is cited and described in Search Report (copy of reference provided by the International Searching Authority).

** Mentioned in Specification.

OTHER DOCUMENTS

EXAMINER INITIAL		AUTHOR, TITLE, DATE, PERTINENT PAGES, ETC.
/SL/		** A. Donges, R. Noll in "Lasermesstechnik" ["Laser Measurement Technology"], Hüthig Verlag, 1993.
/SL/		** H. J. Tiziani, "Optical methods for precision measurements," Optical and Quantum Electronics, Vol. 21, 253-282, 1989.

** Mentioned in Specification

EXAMINER	/Seung Lee/	DATE CONSIDERED	01/05/2009
EXAMINER: Initial if citation considered, whether or not citation is in conformance with M.P.E.P. 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.			

ALL REFERENCES CONSIDERED EXCEPT WHERE LINED THROUGH. /SL/
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